intel®

87C196LA-20 MHz CHMOS 16-bit Microcontroller

Automotive

Advanced Information Datasheet

Product Features

- Up to 20 MHz operation
- 24 Kbytes of on-chip OTPROM
- 768 bytes of on-chip register RAM
- Register-to-register architecture
- Peripheral transaction server (PTS) with high-speed, microcoded interrupt service routines
- Six-channel/10-bit A/D with sample and hold
- High-speed event processor array
 - —Six capture/compare channels
 - -Two compare-only channels
 - —Two 16-bit software timers
- Full-duplex serial I/O port with dedicated baud-rate generator

- Enhanced full-duplex, synchronous serial I/O port (SSIO)
- Programmable 8- or 16-bit external bus
- Selectable clock doubler with programmable clock output signal
- SFR register that indicates the source of the last reset
- Design enhancements for EMI reduction
- Oscillator failure detection circuitry
- Watchdog timer (WDT)
- -40° C to $+125^{\circ}$ C ambient temperature
- 52-pin PLCC package

Notice: This document contains information on products in the sampling and initial production phases of development. The specifications are subject to change without notice. Verify with your local Intel sales office that you have the latest datasheet before finalizing a design.

intel

Information in this document is provided in connection with Intel products. No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document. Except as provided in Intel's Terms and Conditions of Sale for such products, Intel assumes no liability whatsoever, and Intel disclaims any express or implied warranty, relating to sale and/or use of Intel products including liability or warranties relating to fitness for a particular purpose, merchantability, or infringement of any patent, copyright or other intellectual property right. Intel products are not intended for use in medical, life saving, or life sustaining applications.

Intel may make changes to specifications and product descriptions at any time, without notice.

Designers must not rely on the absence or characteristics of any features or instructions marked "reserved" or "undefined." Intel reserves these for future definition and shall have no responsibility whatsoever for conflicts or incompatibilities arising from future changes to them.

The 87C196LA-20 MHz CHMOS 16-bit Microcontroller may contain design defects or errors known as errata which may cause the product to deviate from published specifications. Current characterized errata are available on request.

Contact your local Intel sales office or your distributor to obtain the latest specifications and before placing your product order.

Copies of documents which have an ordering number and are referenced in this document, or other Intel literature may be obtained by calling 1-800-548-4725 or by visiting Intel's website at http://www.intel.com.

Copyright © Intel Corporation, 1998

*Third-party brands and names are the property of their respective owners.



1.0	Introduction					
2.0	Nomenclature Overview	7				
3.0	Pinout	8				
4.0	Signals	11				
5.0	Address Map	17				
6.0	Electrical Characteristics	18				
	 6.1 DC Characteristics	20 20				
7.0	EPROM Specifications					
	7.1 Operating Conditions7.2 EPROM Programming Waveforms					
8.0	A/D Converter Specifications	27				
9.0	AC Characteristics - Serial Port - Shift Register Mode	29				
	 9.1 Test Conditions 9.2 Waveform - Serial Port - Shift Register Mode0 					
10.0	Thermal Characteristics					
11.0	Design Considerations					
12.0	Device Errata					
13.0	Datasheet Revision History					

Figures

1	87C196LA Block Diagram	6
2	Product Nomenclature	7
3	87C196LA 52-pin Package	8
4	System Bus Timing	23
5	External Clock Drive Waveform	24
6	AC Testing Input, Output Waveforms	
7	Float Waveform	24
8	Slave Programming Mode Data Program Mode with Single Program Pulse.	26
9	Slave Programming Mode in WORD Dump or Data Verify Mode with Auto Increment	26
10	Slave Programming Mode Timing in Data Program Mode with Repeated Program Pulse and Auto Increment	27
11	Serial Port Waveform - Shift Register Mode	



Tables

1	Description of Product Nomenclature	7
2	87C196LA 52-pin Package Pin Assignments	9
3	Pin Assignment Arranged by Functional Categories	
4	Signal Descriptions	
5	Address Map	
6	Absolute Maximum Ratings	
7	Operating Conditions	
8	DC Characteristics at V _{CC} = 4.5 V to 5.5 V	
9	AC Characteristics	21
10	AC Timing Symbol Definitions	
11	External Clock Drive	
12	AC EPROM Programming Characteristics	
13	DC EPROM Programming Characteristics	
14	A/D Operating Conditions - Symbol Descriptions	
15	A/D Operating Conditions - Parameter Descriptions	
16	Serial Port Timing - Shift Register Mode	
17	Thermal Characteristics	
18	Revision History	

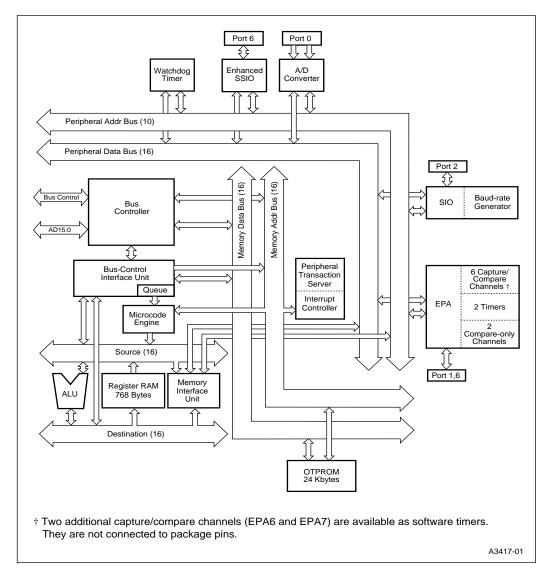
intel®

1.0 Introduction

The 87C196LA is a high-performance 16-bit microcontroller. The 87C196LA is composed of a high-speed core with the following peripherals: an asynchronous/synchronous serial I/O port (8096 compatible) with a dedicated 16-bit baud-rate generator; an additional synchronous serial I/O port with full duplex master/slave transceivers; a six-channel A/D converter with sample and hold; a flexible timer/counter structure with prescaler, cascading, and quadrature capabilities; six modularized, multiplexed high-speed I/O for capture and compare (called event processor array) with 200 ns resolution and double buffered inputs; and a sophisticated, prioritized interrupt structure with programmable peripheral transaction server (PTS). The clock doubler circuitry and oscillator output signal enable a 4 MHz resonator to achieve the same internal clock speed as a more costly 8 MHz resonator in previous applications. This same circuitry can drive other devices where a separate resonator was required in the past. Another cost-savings feature is the fact that the I/O ports are driven low at reset, avoiding the need for pull-up resistors.







2.0 Nomenclature Overview

Figure 2. Product Nomenclature

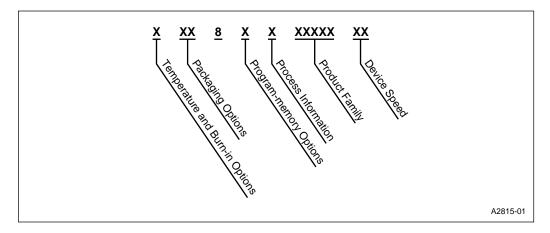
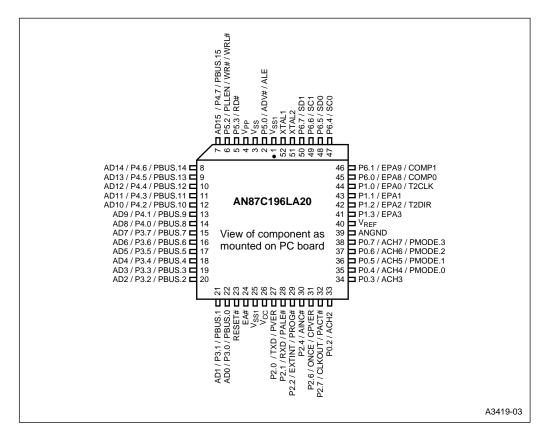


Table 1. Description of Product Nomenclature

Parameter	Options	Description
Temperature and Burn-in Options	А	Automotive operating temperature range (-40°C to 125°C ambient) with Intel standard burn-in.
Packaging Options	Ν	PLCC
Program-memory Options	7	OTPROM
Process Information	С	CHMOS
Product Family	196L <i>x</i>	8XC196Lx family of products
Device Speed	20	20 MHz

3.0 Pinout





Pin	Name	Pin	Name	Pin	Name
1	V _{ss1}	19	AD3 / P3.3 / PBUS.3	37	P0.6 / ACH6 / PMODE.2
2	P5.0 / ADV# / ALE	20	AD2 / P3.2 / PBUS.2	38	P0.7 / ACH7 / PMODE.3
3	V _{SS}	21	AD1 / P3.1 / PBUS.1	39	ANGND
4	V _{PP}	22	AD0 / P3.0 / PBUS.0	40	V _{REF}
5	P5.3 / RD#	23	RESET#	41	P1.3 / EPA3
6	P5.2 / PLLEN / WR# / WRL#	24	EA#	42	P1.2 / EPA2 / T2DIR
7	AD15 / P4.7 / PBUS.15	25	V _{ss1}	43	P1.1 / EPA1
8	AD14 / P4.6 / PBUS.14	26	V _{cc}	44	P1.0 / EPA0 / T2CLK
9	AD13 / P4.5 / PBUS.13	27	P2.0 / TXD / PVER	45	P6.0 / EPA8 / COMP0
10	AD12 / P4.4 / PBUS.12	28	P2.1 / RXD / PALE#	46	P6.1 / EPA9 / COMP1
11	AD11 / P4.3 / PBUS.11	29	P2.2 / EXTINT / PROG#	47	P6.4 / SC0
12	AD10 / P4.2 / PBUS.10	30	P2.4 / AINC#	48	P6.5 / SD0
13	AD9 / P4.1 / PBUS.9	31	P2.6 / ONCE/CPVER	49	P6.6 / SC1
14	AD8 / P4.0 / PBUS.8	32	P2.7 / CLKOUT / PACT#	50	P6.7 / SD1
15	AD7 / P3.7 / PBUS.7	33	P0.2 / ACH2	51	XTAL2
16	AD6 / P3.6 / PBUS.6	34	P0.3 / ACH3	52	XTAL1
17	AD5 / P3.5 / PBUS.5	35	P0.4 / ACH4 / PMODE.0		
18	AD4 / P3.4 / PBUS.4	36	P0.5 / ACH5 / PMODE.1		

Table 2. 87C196LA 52-pin Package Pin Assignments



Addr & Data		Input/Output (Cont'd)		Program Control		Processor Control	
Name	Pin	Name	Pin	Name	Pin	Name	Pin
AD0	22	P2.1 / RXD	28	AINC#	30	EA#	24
AD1	21	P2.2	29	CPVER	31	EXTINT	29
AD2	20	P2.4	30	PACT#	32	PLLEN	6
AD3	19	P2.6	31	PALE#	28	RESET#	23
AD4	18	P2.7	32	PBUS.0	22	XTAL1	52
AD5	17	P3.0	22	PBUS.1	21	XTAL2	51
AD6	16	P3.1	21	PBUS.2	20		
AD7	15	P3.2	20	PBUS.3	19	Bus Cont & S	tatus
AD8	14	P3.3	19	PBUS.4	18	Name	Pin
AD9	13	P3.4	18	PBUS.5	17	ADV# / ALE	2
AD10	12	P3.5	17	PBUS.6	16	CLKOUT	32
AD11	11	P3.6	16	PBUS.7	15	RD#	5
AD12	10	P3.7	15	PBUS.8	14	WR#/WRL#	6
AD13	9	P4.0	14	PBUS.9	13		
AD14	8	P4.1	13	PBUS.10	12	Power & Ground	
AD15	7	P4.2	12	PBUS.11	11	Name	Pin
		P4.3	11	PBUS.12	10	ANGND	39
Input/Outp	out	P4.4	10	PBUS.13	9	V _{cc}	26
Name	Pin	P4.5	9	PBUS.14	8	V _{PP}	4
P0.2 / ACH2	33	P4.6	8	PBUS.15	7	V _{REF}	40
P0.3 / ACH3	34	P4.7	7	PMODE.0	35	V _{SS}	3
P0.4 / ACH4	35	P5.0	2	PMODE.1	36	V _{ss1}	1
P0.5 / ACH5	36	P5.2	6	PMODE.2	37	V _{ss1}	25
P0.6 / ACH6	37	P5.3	5	PMODE.3	38		
P0.7 / ACH7	38	P6.0 / EPA8 / COMP0	45	PROG#	29		
P1.0 / EPA0 / T2CLK	44	P6.1 / EPA9 / COMP1	46	PVER	27		
P1.1 / EPA1	43	P6.4 / SC0	47				
P1.2 / EPA2 / T2DIR	42	P6.5 / SD0	48				
P1.3 / EPA3	41	P6.6 / SC1	49				
P2.0 / TXD	27	P6.7 / SD1	50				

Table 3. Pin Assignment Arranged by Functional Categories

4.0 Signals

Table 4. Signal Descriptions (Sheet 1 of 6)

Name	Туре	Description
ACH7:2	I	Analog Channels These signals are analog inputs to the A/D converter. The A/D inputs share package pins with port 0. These pins may individually be used as analog inputs (ACH <i>x</i>) or digital inputs (P0. <i>y</i>). While it is possible for the pins to function simultaneously as analog and digital inputs, this is not recommended because reading port 0 while a conversion is in process can produce unreliable conversion results. The ANGND and V _{REF} pins must be connected for the A/D converter and port 0 to function. ACH7:2 share package pins with the following signals: ACH2/P0.2, ACH3/P0.3, ACH4/P0.4/PMODE.0, ACH5/P0.5/PMODE.1, ACH6/P0.6/PMODE.2, and ACH7/ P0.7/PMODE.3.
AD15:0	I/O	Address/Data Lines These pins provide a multiplexed address and data bus. During the address phase of the bus cycle, address bits 0–15 are presented on the bus and can be latched using ALE or ADV#. During the data phase, 8- or 16-bit data is transferred. AD7:0 share package pins with P3.7:0 and PBUS.7:0. AD15:8 share package pins with P4.7:0 and PBUS.15:8.
ADV#	0	Address Valid This active-low output signal is asserted only during external memory accesses. ADV# indicates that valid address information is available on the system address/ data bus. The signal remains low while a valid bus cycle is in progress and is returned high as soon as the bus cycle completes. An external latch can use this signal to demultiplex the address from the address/ data bus. A decoder can also use this signal to generate chip selects for external memory. ADV# shares a package pin with P5.0 and ALE.
AINC#	I	Auto Increment During slave programming, this active-low input enables the auto-increment feature. (Auto increment allows reading or writing of sequential OTPROM locations, without requiring address transactions across the programming bus for each read or write.) AINC# is sampled after each location is programmed or dumped. If AINC# is asserted, the address is incremented and the next data word is programmed or dumped. AINC# shares a package pin with P2.4.



Name	Туре	Description
		Address Latch Enable
ALE	0	This active-high output signal is asserted only during external memory cycles. ALE signals the start of an external bus cycle and indicates that valid address information is available on the system address/data bus.
		An external latch can use this signal to demultiplex the address from the address/ data bus.
		ALE shares a package pin with P5.0 and ADV#.
		Analog Ground
ANGND	GND	ANGND must be connected for A/D converter and port 0 operation. ANGND and $\rm V_{SS}$ should be nominally at the same potential.
		Clock Output
CLKOUT	ο	Output of the internal clock generator. You can select one of three frequencies: f, f/2, or f/4. CLKOUT has a 50% duty cycle.
		CLKOUT shares a package pin with P2.7 and PACT#.
		Event Processor Array (EPA) Compare Pins
COMP1:0	ο	These signals are the outputs of the EPA compare-only channels.
		COMP1:0 share package pins with the following signals: COMP0/P6.0/EPA8 and COMP1/P6.1/EPA9.
		Cumulative Program Verification
CPVER	0	During slave or programming, a high signal indicates that all locations programmed correctly, while a low signal indicates that an error occurred during the program operation.
		CPVER shares a package pin with P2.6 and ONCE#.
		External Access
EA#	1	This input determines whether memory accesses to special-purpose and program memory partitions are directed to internal or external memory. These accesses are directed to internal memory if EA# is held high and to external memory if EA# is held low. For an access to any other memory location, the value of EA# is irrelevant.
		EA# also controls entry into the programming modes. If EA# is at V_{PP} voltage (typically +12.5 V) on the rising edge of RESET#, the microcontroller enters a programming mode.
		EA# is sampled and latched only on the rising edge of RESET#. Changing the level of EA# after reset has no effect.
		Event Processor Array (EPA) Capture/Compare Channels
		High-speed input/output signals for the EPA capture/compare channels.
EPA9:8 EPA3:0	I/O	The EPA signals share package pins with the following signals: EPA0/P1.0/T2CLK, EPA1/P1.1, EPA2/P1.2/T2DIR, EPA3/P1.3, EPA8/P6.0/COMP0, and EPA9/P6.1/COMP1. EPA7:6 do not connect to package pins. They cannot be used to capture an event, but they can function as software timers. EPA5:4 are not implemented.

Table 4. Signal Descriptions (Sheet 2 of 6)



Name	Туре	Description
	1	External Interrupt
		In normal operating mode, a rising edge on EXTINT sets the EXTINT interrupt pending bit. EXTINT is sampled during phase 2. The minimum high time is one state time.
EXTINT	I	In powerdown mode, asserting the EXTINT signal causes the device to resume normal operation. The interrupt does not need to be enabled.
		In idle mode, asserting any enabled interrupt causes the device to resume normal operation.
		EXTINT shares a package pin with P2.2 and PROG#.
		Port 0
		This is a high-impedance, input-only port. Port 0 pins should not be left floating.
P0.7:2	I	The port 0 signals share package pins with the A/D inputs. These pins may individually be used as analog inputs (ACH x) or digital inputs (P0 $,y$). While it is possible for the pins to function simultaneously as analog and digital inputs, this is not recommended because reading port 0 while a conversion is in process can produce unreliable conversion results.
		ANGND and V_{REF} must be connected for port 0 to function.
		P0.3:2 share package pins with ACH3:2 and P0.7:4 share package pins with ACH7:4 and PMODE.3:0.
		Port 1
P1.3:0	I/O	This is a standard bidirectional port that shares package pins with individually selectable special-function signals.
		Port 1 shares package pins with the following signals: P1.0/EPA0/T2CLK, P1.1/ EPA1, P1.2/EPA2/T2DIR, P1.3/EPA3.
		Port 2
P2.7:6		This is a standard bidirectional port that shares package pins with individually selectable special-function signals.
P2.4 P2.2:0	I/O	Port 2 shares package pins with the following signals: P2.0/TXD/PVER, P2.1/RXD/ PALE#, P2.2/EXTINT/PROG#, P2.4/AINC#, P2.6/ONCE/CPVER.
		P2.7/OSCOUT/PACT# is output pin only.
		Port 3
P3.7:0	I/O	This is a memory-mapped, 8-bit, bidirectional port with programmable open-drain or complementary output modes. The pins are shared with the multiplexed address/data bus, which has complementary drivers.
		P3.7:0 share package pins with AD7:0 and PBUS.7:0.
		Port 4
P4.7:0	I/O	This is a memory-mapped, 8-bit, bidirectional port with open-drain or complementary output modes. The pins are shared with the multiplexed address/ data bus, which has complementary drivers.
		P4.7:0 share package pins with AD15:8 and PBUS.15:8.
	1	Port 5
P5.3:2	I/O	This is a memory-mapped, bidirectional port.
P5.0		Port 5 shares package pins with the following signals: P5.0/ADV#/ALE, P5.2/WR#/ WRL#/PLLEN, and P5.3/RD#. P5.1 and P5.7:4 are not implemented.

Table 4. Signal Descriptions (Sheet 3 of 6)



Name	Туре	Description
		Port 6
P6.7:4	0	This is a standard bidirectional port.
P6.1:0	0	Port 6 shares package pins with the following signals: P6.0/EPA8/COMP0, P6.1/EPA9/COMP1, P6.4/SC0, P6.5/SD0, P6.6/SC1, and P6.7/SD1.
		Programming Active
PACT#	ο	During auto programming or slave dump, a low signal indicates that programming or dumping is in progress, while a high signal indicates that the operation is complete.
		PACT# shares a package pin with P2.7 and OSCOUT.
		Programming ALE
PALE#	I	During slave programming, a falling edge causes the device to read a command and address from the programming bus. PALE# is multiplexed with P2.1 and RXD.
		Address/Command/Data Bus
		During slave programming, ports 3 and 4 serve as a bidirectional port with open- drain outputs to pass commands, addresses, and data to or from the device. Slave programming requires external pull-up resistors.
PBUS.15:0	1/0	During auto programming and ROM-dump, ports 3 and 4 serve as a regular system bus to access external memory. P4.6 and P4.7 are left unconnected; P1.1 and P1.2 serve as the upper address lines.
	10	Slave programming: PBUS.7:0 share package pins with AD7:0 and P3.7:0.
		PBUS.15:8 share package pins with AD15:8 and P4.7:0.
		Auto programming: PBUS.15:8 share package pins with AD15:8 and P4.7:0; PBUS.7:0 share package pins with AD7:0 and P3.7:0.
	I	Phase-locked Loop Enable
PLLEN		This active-high input pin enables the on-chip clock multiplier. Tie this pin to V_{CC} a power-up to bypass the on-chip clock multiplier.
		Programming Mode Select
PMODE.3:0	I	These pins determine the programming mode. PMODE3:0 are sampled after a device reset and must be static while the microcontroller is operating.
		PMODE3:0 share package pins with P0.7:4 and ACH7:4.
		Programming Start
PROG#	I	During programming, a falling edge latches data on the programming bus and begins programming, while a rising edge ends programming. The current location is programmed with the same data as long as PROG# remains asserted, so the data on the programming bus must remain stable while PROG# is active.
		During a word dump, a falling edge causes the contents of an OTPROM location t be output on the PBUS, while a rising edge ends the data transfer.
		PROG# shares a package pin with P2.2 and EXTINT.
		Program Verification
		During slave or auto programming, PVER is updated after each programming
PVER	0	pulse. A high output signal indicates successful programming of a location, while low signal indicates a detected error.

Table 4. Signal Descriptions (Sheet 4 of 6)



Name	Туре	Description
		Read
RD#	ο	Read-signal output to external memory. RD# is asserted during external memory reads.
		RD# shares a package pin with P5.3.
		Reset
RESET#	I/O	A level-sensitive reset input to, and an open-drain system reset output from, the microcontroller. Either a falling edge on RESET# or an internal reset turns on a pull-down transistor connected to the RESET# pin for 16 state times.
		In the powerdown and idle modes, asserting RESET# causes the microcontroller to reset and return to normal operating mode. After a reset, the first instruction fetch is from 2080H.
		Receive Serial Data
RXD	I/O	In modes 1, 2, and 3, RXD receives serial port input data. In mode 0, it functions as either an input or an open-drain output for data.
		RXD shares a package pin with P2.1 and PALE#.
		Clock Pins for SSIO0 and 1
		For handshaking transfers, configure SC1:0 as open-drain outputs.
SC1:0	I/O	This pin carries a signal only during receptions and transmissions. When the SSIO port is idle, the pin remains either high (with handshaking) or low (without handshaking).
		SC0 shares a package pin with P6.4, and SC1 shares a package pin with P6.6.
		Data Pins for SSIO0 and 1
SD1:0	I/O	These pins are the data I/O pins for SSIO0 and 1. For transmissions, configure SD x as a complementary output signal. For receptions, configure SD x as a high-impedance input signal.
		SD0 shares a package pin with P6.5, and SD1 shares a package pin with P6.7.
		Timer 2 External Clock
T2CLK	I	External clock for timer 2. Timer 2 increments (or decrements) on both rising and falling edges of T2CLK. It is also used in conjunction with T2DIR for quadrature counting mode.
		T2CLK shares a package pin with P1.0 and EPA0.
		Timer 2 External Direction
T2DIR	I	External direction (up/down) for timer 2. Timer 2 increments when T2DIR is high and decrements when it is low. It is also used in conjunction with T2CLK for quadrature counting mode.
		T2DIR shares a package pin with P1.2 and EPA2.
		Transmit Serial Data
TXD	о	In serial I/O modes 1, 2, and 3, TXD transmits serial port output data. In mode 0, it is the serial clock output.
		TXD shares a package pin with P2.0 and PVER.

Table 4. Signal Descriptions (Sheet 5 of 6)



Name	Туре	Description
V	PWR	Digital Supply Voltage
V _{cc}		Connect each V_{cc} pin to the digital supply voltage.
		Programming Voltage
V _{PP}	PWR	$V_{\rm PP}$ causes the device to exit powerdown mode when it is driven low for at least 50 ns. Use this method to exit powerdown only when using an external clock source because it enables the internal phase clocks, but not the internal oscillator.
		If you do not plan to use the powerdown feature, connect $V_{\mbox{\tiny PP}}$ to $V_{\mbox{\tiny CC}}.$
V	PWR	Reference Voltage for the A/D Converter
V _{REF}	FWIN	This pin supplies operating voltage to the A/D converter.
		Digital Circuit Ground
V _{SS} , V _{SS1}	GND	These pins supply ground for the digital circuitry. Connect each V _{SS} and V _{SS1} pin to ground through the lowest possible impedance path. V _{SS} pins are connected to the core ground region of the microcontroller, while V _{SS1} pins are connected to the port ground region. (ANGND is connected to the analog ground region.) Separating the ground regions provides noise isolation.
		Write [†]
	ο	This active-low output indicates that an external write is occurring. This signal is asserted only during external memory writes.
WR#		Forcing WR# high while RESET# is low causes the device to enter PLL-bypass mode. When the device is in PLL-bypass mode, the internal phase clocks operate at one-half the frequency of the frequency on XTAL1.
		WR# shares a package pin with P5.2, WRL#, and PLLEN.
		[†] When this pin is configured as a special-function signal (P5_MODE.2 = 1), the chip configuration register 0 (CCR0) determines whether it functions as WR# or WRL#. CCR0.2 = 1 selects WR#; CCR0.2 = 0 selects WRL#.
		Write Low [†]
WRL#		During 16-bit bus cycles, this active-low output signal is asserted for low-byte writes and word writes to external memory. During 8-bit bus cycles, WRL# is asserted for all write operations.
WKL#	0	WRL# shares a package pin with P5.2, WR#, and PLLEN.
		[†] When this pin is configured as a special-function signal (P5_MODE.2 = 1), the chip configuration register 0 (CCR0) determines whether it functions as WR# or WRL#. CCR0.2 = 1 selects WR#; CCR0.2 = 0 selects WRL#.
		Input Crystal/Resonator or External Clock Input
XTAL1	I	Input to the on-chip oscillator and the internal clock generators. The internal clock generators provide the peripheral clocks, CPU clock, and CLKOUT signal. When using an external clock source instead of the on-chip oscillator, connect the clock input to XTAL1. The external clock signal must meet the V _{IH} specification for XTAL1.
		Inverted Output for the Crystal/Resonator
XTAL2	0	Output of the on-chip oscillator inverter. Leave XTAL2 floating when the design uses an external clock source instead of the on-chip oscillator.

Table 4. Signal Descriptions (Sheet 6 of 6)

5.0 Address Map

Table 5. Address Map

Hex Address Range	Description	Addressing Modes
FFFF 8000	External device (memory or I/O) connected to address/data bus	Indirect or indexed
7FFF 2080	Program memory (internal nonvolatile or external memory); see Note 1.	Indirect or indexed
207F 2000	Special-purpose memory (internal nonvolatile or external memory)	Indirect or indexed
1FFF 1FE0	Memory-mapped SFRs	Indirect or indexed
1FDF 1F00	Peripheral SFRs	Indirect, indexed, or windowed direct
1EFF 0300	External device (memory or I/O) connected to address/data bus; (future SFR expansion; see Note 2).	Indirect or indexed
02FF 0100	Upper register file (general-purpose register RAM)	Indirect, indexed, or windowed direct
00FF 0000	Lower register file (register RAM, stack pointer, and CPU SFRs)	Direct, indirect, or indexed

NOTES:

1. After a reset, the microcontroller fetches its first instruction from 2080H.

2. The content or function of these locations may change in future microcontroller revisions, in which case a program that relies on a location in this range might not function properly.

Electrical Characteristics 6.0

Note: This document contains information on products in the design phase of development. Do not finalize a design with this information. Revised information will be published when the product is available. Verify with your local Intel sales office that you have the latest datasheet before finalizing a design.

Table 6. Absolute Maximum Ratings

Parameter	Maximum Rating
Storage Temperature	-60°C to +150°C
Voltage from V_{PP} or EA# to V_{SS} or ANGND	–0.5 V to +13.0 V
Voltage from any other pin to V_{SS} or ANGND	-0.5 V to +7.0 V
Power Dissipation	0.5 W

Warning: Stressing the device beyond the "Absolute Maximum Ratings" may cause permanent damage. These are stress ratings only.

Table 7. Operating Conditions

Parameter	Values
T _A (Ambient Temperature Under Bias)	-40°C to +125°C
V _{CC} (Digital Supply Voltage)	4.75 V to 5.25 V
V _{REF} (Analog Supply Voltage) (Notes 1, 2)	4.75 V to 5.25 V
F _{XTAL1} (Input Frequency): - PLL in 2x mode - PLL bypassed	4 MHz to 10 MHz 8 MHz to 20 MHz

NOTES:

1. ANGND and V_{SS} should be nominally at the same potential. 2. V_{REF} should not exceed V_{CC} by more than 0.5 V.

Operation beyond the "Operating Conditions" is not recommended and extended exposure beyond Warning: the "Operating Conditions" may affect device reliability.



DC Characteristics 6.1

Symbol	Parameter	Min	Typical	Max	Units	Test Conditions (Note 1)
I _{CC}	V _{CC} supply current (-40°C to +125°C ambient)		50	95	mA	F _{XTAL 1} = 20 MHz,
I _{CC1}	Active mode supply current (typical)		50		mA	$V_{CC} = V_{PP} = V_{REF} = 5.25 V$ (While device is in reset)
I _{REF}	A/D reference supply current		2	5	mA	
I _{IDLE}	Idle mode current		15	42	mA	$\begin{array}{l} F_{XTAL1} = 20 \text{ MHz}, \\ V_{CC} = V_{PP} = V_{REF} = 5.25 \text{ V} \end{array}$
V _{IL}	Input low voltage (all pins)	0.5 V		0.3 V _{CC}	V	
V _{IH}	Input high voltage (all pins)	0.7 V _{CC}		V _{CC} + 0.5	V	(3)
V _{OL}	Output low voltage (outputs configured as complementary)			0.3 0.45 1.5	>>>	$I_{OL} = 200 \ \mu A (4)$ $I_{OL} = 3.2 \ m A$ $I_{OL} = 7.0 \ m A$
V _{OH}	Output high voltage (outputs configured as complementary)	$V_{CC} - 0.3$ $V_{CC} - 0.7$ $V_{CC} - 1.5$			> >	$I_{OH} = -200 \ \mu A (4)$ $I_{OH} = -3.2 \ m A$ $I_{OH} = -7.0 \ m A$
ILI	Input leakage current (standard inputs)			± 8	μA	$V_{SS} \le V_{IN} \le V_{CC} (5)$
I _{LI1}	Input leakage current (port 0—A/D inputs)			± 1	μA	$V_{SS} \le V_{IN} \le V_{REF}$
V _{OL2}	Output low voltage in reset (all pins except P2.6)			1	V	I _{OL} = 15 μA (6, 7)
I _{OL2}	Output low current in reset (all pins except P2.6)	15 30 35		110 185 215	μΑ μΑ μΑ	V _{OL2} = 1.0 V V _{OL2} = 2.5 V V _{OL2} = 4.0 V
R _{RST}	Reset pullup resistor	6 K		65 K	Ω	
V _{OL3}	Output low voltage in reset (RESET# pin only)			0.3 0.5 0.8	V V V	$I_{OL3} = 4 \text{ mA} (7)$ $I_{OL3} = 6 \text{ mA}$ $I_{OL3} = 10 \text{ mA}$
V _{OL4}	Output low voltage in reset (P2.6 only)			1	V	I _{OL4} = 500 μA

Table 8. DC Characteristics at V_{CC} = 4.75 V to 5.25 V (Sheet 1 of 2)

NOTES:

1. Device is static and should operate below 1 Hz, but is tested only down to 4 MHz with the PLL enabled. With the PLL bypassed, the device is tested only down to 8 MHz.

Typicals are based on a limited number of samples and are not guaranteed. The values listed are at room temperature and V_{REF} = V_{CC} = 5.25 V.
 V_{IH} max for port 0 is V_{REF} + 0.5 V.
 All bidirectional pins when configured as complementary outputs.

5. Standard input pins include XTAL1, EA#, RESET#, and ports 1-6 when configured as inputs.

6. All bidirectional pins except P2.7/CLKOUT, which is excluded because it is not weakly pulled low in reset. Bidirectional pins include ports 1-6.

7. This specification is not tested in production and is based upon theoretical estimates and/or product characterization.

Symbol	Parameter	Min	Typical	Max	Units	Test Conditions (Note 1)
C _S	Pin capacitance (any pin to V _{ss})			10	pF	F _{TEST} = 1.0 MHz
R _{WPD2}	Weak pulldown resistance (all pins except P2.6)		~100 K		Ω	(Note 2)
I _{OL4}	P2.6 only	0.4 1.0 1.2		2.0 3.5 4.0	mA mA mA	V _{OL4} = 1.0 V V _{OL4} = 2.5 V V _{OL4} = 4.0 V
R_{WPD4}	P2.6 only		3 K		Ω	

Table 8. DC Characteristics at V_{CC} = 4.75 V to 5.25 V (Sheet 2 of 2)

NOTES:

1. Device is static and should operate below 1 Hz, but is tested only down to 4 MHz with the PLL enabled. With the PLL bypassed, the device is tested only down to 8 MHz.

2. Typicals are based on a limited number of samples and are not guaranteed. The values listed are at room temperature and V_{REF} = V_{CC} = 5.25 V. 3. V_{IH} max for port 0 is V_{REF} + 0.5 V.

- 4. All bidirectional pins when configured as complementary outputs.
- 5. Standard input pins include XTAL1, EA#, RESET#, and ports 1-6 when configured as inputs.

6. All bidirectional pins except P2.7/CLKOUT, which is excluded because it is not weakly pulled low in reset. Bidirectional pins include ports 1-6.

7. This specification is not tested in production and is based upon theoretical estimates and/or product characterization.

6.2 AC Characteristics (Over Specified Operating Conditions)

6.2.1 **Test Condition**

- Capacitive load on all pins = 100 pF
- Rise and fall times = 10 ns
- F_{XTAL1} = 8 MHz with PLL enabled in clock-doubler mode

Symbol	Parameter	Min	Max	Units
	The 87C196LA meets these	specifications		•
-	Frequency on XTAL1, PLL bypassed	8	20	NUL (1)
F _{XTAL1}	Frequency on XTAL1, PLL in 2x mode	4	10	— MHz ⁽¹⁾
	Operating frequency, f = F _{XTAL1} ; PLL in 1x mode			
f	Operating frequency, $f = 2F_{XTAL1}$; PLL in 2x mode	8	20	MHz
t	Period t = 1/f	50	125	ns
T _{XHCH}	XTAL1 High to CLKOUT High or Low	20	110	ns ⁽²⁾
T _{CLCL}	CLKOUT Cycle Time		2t	ns
T _{CHCL}	CLKOUT High Period	t - 10	t + 20	ns
T _{CLLH}	CLKOUT Falling to ALE Rising	- 10	30	ns
T _{LLCH}	ALE Falling to CLKOUT Rising	- 35	15	ns
T _{LHLH}	ALE Cycle Time		4t	ns
T _{LHLL}	ALE High Period	t - 10	t + 10	ns
T _{AVLL}	Address Setup to ALE Low	t - 15		ns
T _{LLAX}	Address Hold after ALE Low	t - 40		ns
T _{LLRL}	ALE Low to RD# Low	t 30		ns
T _{RLCL}	RD# Low to CLKOUT Low	0	30	ns
T _{RHLH}	RD# High to ALE Rising	t - 5		ns
T _{RLRH}	RD# Low to RD# High	t	t + 25	ns ⁽³⁾
T _{RLAZ}	RD# Low to Address Float		10	ns
T _{LLWL}	ALE Low to WR# Low	t - 10		ns
T _{CLWL}	CLKOUT Low to WR# Falling Edge	- 5	25	ns
T _{QVWH}	Data Valid to WR# High	t - 23		ns
T _{CHWH}	CLKOUT High to WR# Rising Edge	- 5	30	ns
T _{WLWH}	WR# Low to WR# High	t - 20		ns
T _{WHQX}	Data Hold after WR# High	t - 25		ns
T_{WHLH}	WR# High to ALE High	t - 10	t + 15	ns ⁽³⁾
T _{WHAX}	AD15:8 Hold after WR# High	t - 30		ns ⁽⁴⁾
T _{RHAX}	AD15:8 Hold after RD# High	t - 30	T	ns ⁽⁴⁾

Table 9. AC Characteristics (Sheet 1 of 2)

NOTES:

Testing performed at 4.0 MHz with PLL enabled. With the PLL bypassed, the device is tested only down to 8 MHz. However, the device is static by design and typically operates below 1 Hz.
 Typical specifications, not guaranteed.

Assuming back-to-back bus cycles.
 8-bit bus only.



Table 9. AC Characteristics (Sheet 2 of 2)

Symbol	Parameter	Min	Мах	Units
	The system must meet these specification	s to work with th	e 87C196LA	
T _{AVDV}	Address Valid to Input Data Valid		3t - 55	ns
T _{RLDV}	RD# Low to Input Data Valid		t - 22	ns
T _{CLDV}	CLKOUT Low to Input Data Valid		t - 50	ns
T _{RHDZ}	RD# High to Input Data Float		t	ns
T _{RXDX}	Data Hold after RD# Inactive	0		ns

NOTES:

1. Testing performed at 4.0 MHz with PLL enabled. With the PLL bypassed, the device is tested only down to 8 MHz. However, the device is static by design and typically operates below 1 Hz.

2. Typical specifications, not guaranteed.

3. Assuming back-to-back bus cycles.

4. 8-bit bus only.

6.2.2 Explanation of AC Symbols

Each symbol is two pairs of letters prefixed by "t" for time. The characters in a pair indicate a signal and its condition, respectively. Symbols represent the time between the two signal/condition points.

Table 10. AC Timing Symbol Definitions

A	AD15:0
С	CLKOUT
D	AD15:0, AD7:0
L	ALE
Q	AD15:0, AD7:0
R	RD#
W	WR#, WRL#

Character	Condition
Н	High
L	Low
V	Valid
Х	No Longer Valid
Z	Floating (low impedance)

intel®

Figure 4. System Bus Timing

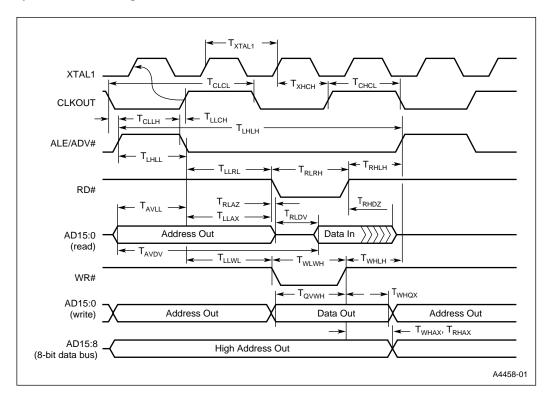


Table 11. External Clock Drive

Symbol	Parameter	Min	Max	Units
1/T.	Frequency on X _{TAL1} , PLL bypassed	8	20	MHz ⁽¹⁾
1/T _{XLXL}	Frequency on X _{TAL1} , PLL in 2x mode	4	10	
T _{XLXL}	Oscillator Period (T _{OSC})	50	250	ns
T _{XHXX}	High Time	0.35T	0.65T	ns
T _{XLXX}	Low Time	0.35T	0.65T	ns
T _{XLXH}	Rise Time		10	ns
T _{XHLX}	Fall Time		10	ns

1. Testing performed at 4.0 MHz with PLL enabled. With the PLL bypassed, the device is tested only down to 8 MHz. However, the device is static by design and typically operates below 1 Hz.

Figure 5. External Clock Drive Waveform

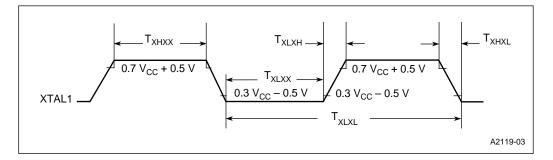


Figure 6. AC Testing Input, Output Waveforms

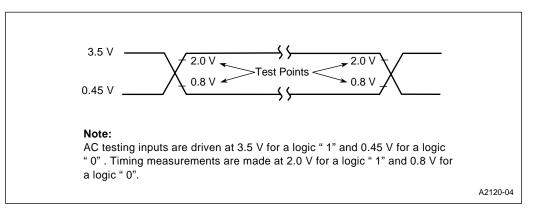
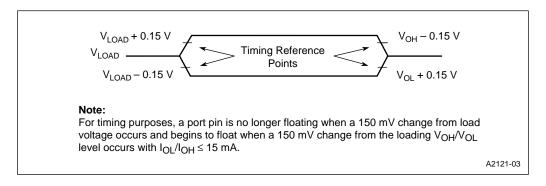


Figure 7. Float Waveform



EPROM Specifications 7.0

Operating Conditions 7.1

- Load Capacitance = 150 pF
- T_C = 25°C ±5°C
- V_{SS}
- EA# = 12.5 V ±0.25 V

- V_{REF} = 5.0 V ±0.25 V
- ANGND = 0.0 V • VPP = 12.5 V ±0.25 V
- F_{OSC} = 5.0 MHz

Table 12. AC EPROM Programming Characteristics

Symbol	Parameter	Min	Max	Units
T _{AVLL}	Address Setup Time	0		T _{OSC}
T _{LLAX}	Address Hold Time	100		T _{OSC}
T _{DVPL}	Data Setup Time	0		T _{OSC}
T _{PLDX}	Data Hold Time	400		T _{OSC}
T _{LLLH}	PALE# Pulse Width	50		T _{OSC}
T _{PLPH}	PROG# Pulse Width ³	50		T _{OSC}
T _{LHPL}	PALE# High to PROG# Low	220		T _{OSC}
T _{PHLL}	PROG# High to Next PALE# Low	220		T _{OSC}
T _{PHDX}	Word Dump Hold Time		50	T _{OSC}
T _{PHPL}	PROG# High to Next PROG# Low	220		T _{OSC}
T _{LHPL}	PALE# High to PROG# Low	220		T _{OSC}
T _{PLDV}	PROG# Low to Word Dump Valid		50	T _{OSC}
T _{SHLL}	RESET# High to First PALE# Low	1100		T _{OSC}
T _{PHIL}	PROG# High to AINC# Low	0		T _{OSC}
T _{ILIH}	AINC# Pulse Width	240		T _{OSC}
T _{ILVH}	PVER# Hold after AINC# Low	50		T _{OSC}
T _{ILPL}	AINC# Low to PROG# Low	170		T _{OSC}
T _{PHVL}	PROG# High to PVER# Valid		220	T _{OSC}

NOTES:

1. Run-time programming is done with F_{OSC} = 6.0 MHz to 10.0 MHz, V_{CC}, V_{PD}, V_{REF} = 5.0 V ±0.25 V, T_C = 25°C ±5°C and V_{PP} = 12.5 V ±0.25 V. For run-time programming over a full operating range, contact factory.

2. Programming Specifications are not tested, but guaranteed by design.

3. This specification is for the word dump mode. For programming pulses use 300 T_{OSC} + 100 μ s.

Table 13. DC EPROM Programming Characteristics

Symbol	Parameter	Min	Мах	Units
I _{PP}	V _{PP} Programming Supply Current		100	mA

NOTE: V_{PP} must be within 1 V of V_{CC} while V_{CC} <4.5 V. V_{PP} must not have a low impedance path to ground or V_{SS} while V_{CC} >4.5 V.

7.2 EPROM Programming Waveforms

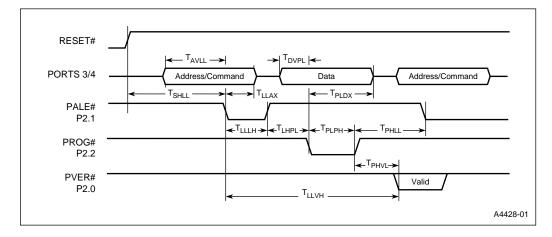
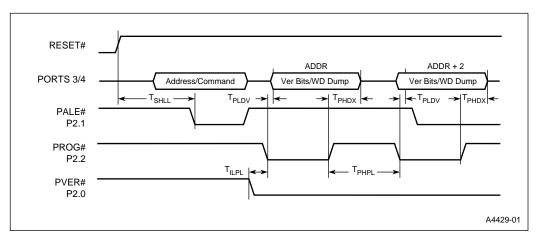
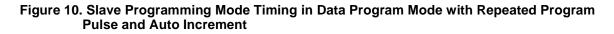
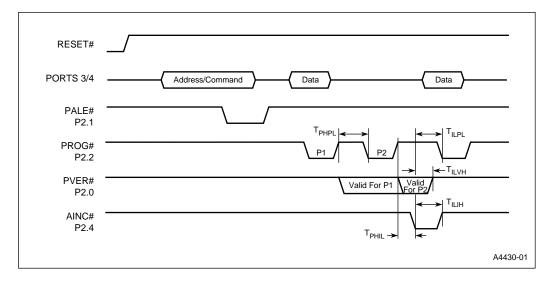


Figure 8. Slave Programming Mode Data Program Mode with Single Program Pulse









8.0 A/D Converter Specifications

The speed of the A/D converter in the 10-bit or 8-bit modes can be adjusted by setting the AD_TIME special function register to the appropriate value. The AD_TIME register only programs the speed at which the conversions are performed, not the speed at which it can convert correctly.

The converter is ratiometric, so absolute accuracy is dependent on the accuracy and stability of V_{REF} . V_{REF} must be within 0.5 V of V_{CC} since it supplies both the resistor ladder and the digital portion of the converter and input port pins.

For testing purposes, after a conversion is started, the device is placed in the IDLE mode until the conversion is complete. Testing is performed at $V_{REF} = 5.12$ V and 20 MHz operating frequency.

There is an AD_TEST register that allows for conversion on ANGND and V_{REF} , as well as zero offset adjustment. The absolute error listed is without doing any adjustments.

Table 14.	A/D Operatii	ng Conditions - Symbol Descriptions ¹	

Symbol	Description	Min	Max	Units
T _A	Automotive Ambient Temperature	-40	+125	°C
V _{CC}	Digital Supply Voltage	4.75	5.25	V
V _{REF}	Analog Supply Voltage	4.75	5.25 ^(2,3)	V
T _{SAM}	Sample Time	2.0		µs ⁽⁴⁾
T _{CONV}	CONV Conversion Time		18	µs ⁽⁴⁾
F _{OSC}	Oscillator Frequency	4	20	MHz

NOTES:

1. ANGND and V_{SS} should nominally be at the same potential. 2. V_{REF} must not exceed V_{CC} by more than +0.5 V. 3. Testing is performed at V_{REF} = 5.12 V. 4. The value of AD_TIME must be selected to meet these specifications.

Table 15. A/D Operating Conditions - Parameter Descriptions

Parameter	Typical ^{†,1}	Min	Мах	Units [‡]
Resolution		1024 10	1024 10	Level Bits
Absolute Error		0	±3	LSBs
Full Scale Error	±2			LSBs
Zero Offset Error	±2			LSBs
Non-Linearity			±3	LSBs
Differential Non-Linearity		≥0.5	+0.5	LSBs
Channel-to-Channel Matching		0	±1	LSBs
Repeatability	±0.25	0		LSBs ⁽¹⁾
Temperature Coefficients: Offset Fullscale Differential Non-Linearity	0.009			LSBs/C ⁽¹⁾
Off Isolation		- 60		dB ^(1,2,3)
Feedthrough	- 60			dB ^(1,2)
V _{CC} Power Supply Rejection	- 60			dB ^(1,2)
Input Resistance		750	1.2 K	Ω ⁽¹⁾
DC Input Leakage		0	2	μA

NOTES:

[†] These values are expected for most parts at 25°C, but are not tested or guaranteed.

[‡] An "LSB", as used here, has a value of approximately 5 mV. (See Automotive Handbook for A/D glossary of terms).

1. These values are not tested in production and are based on theoretical estimates and/or laboratory test.

2. DC to 100 KHz.

3. Multiplexer Break-Make Guaranteed.

9.0 AC Characteristics - Serial Port -Shift Register Mode

9.1 Test Conditions

• V_{SS} = 0.0 V

• V_{CC} = 5.0 V ±5%

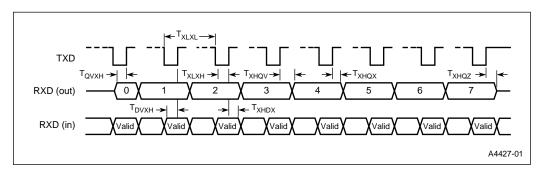
- Load Capacitance = 100 pF
- Table 16. Serial Port Timing Shift Register Mode

Symbol	Parameter	Min	Мах	Units
T _{XLXL}	Serial Port Clock Period	8T		ns
T _{XLXH}	Serial Port Clock Falling Edge to Rising Edge	4T - 50	4T + 50	ns
T _{QVXH}	Output Data Setup to Clock Rising Edge	ЗT		ns
T _{XHQX}	Output Data Hold after Clock Rising Edge	2T - 50		ns
T _{XHQV}	Next Output Data Valid after Clock Rising Edge		2T + 50	ns
T _{DVXH}	Input Data Setup to Clock Rising Edge	2T + 200		ns
T _{XHDX} ¹	Input Data Hold after Clock Rising Edge	0		ns
T _{XHQZ} ¹	Last Clock Rising to Output Float		5T	ns

1. Parameter not tested.

9.2 Waveform - Serial Port - Shift Register Mode0

Figure 11. Serial Port Waveform - Shift Register Mode





10.0 Thermal Characteristics

All thermal impedance data is approximate for static air conditions at 1 watt of power dissipation. Values change depending on operating conditions and the application. The Intel *Packaging Handbook* (order number 240800) describes Intel's thermal impedance test methodology. The *Components Quality and Reliability Handbook* (order number 210997) provides quality and reliability information.

Table 17. Thermal Characteristics

Package Type	θ_{JA}	ог ^θ
AN87C196LA (52-pin PLCC)	42°C/W	15°C/W

NOTES:

1. θ_{JA} = Thermal resistance between junction and the surrounding environment (ambient). Measurements are taken 1 foot away from case in static air flow environment.

 θ_{JC} = Thermal resistance between junction and package surface (case).

All values of θ_{JA} and θ_{JC} may fluctuate depending on the environment (with or without airflow, and how much airflow) and device power dissipation at temperature of operation. Typical variations are ± 2°C/W.
 Values listed are at a maximum power dissipation of 0.5 W.

11.0 Design Considerations

To be supplied.

12.0 Device Errata

Contact your Intel sales representative for this product's specification update.

13.0 Datasheet Revision History

This is the (003) version of the 87C196LA-20 MHz CHMOS 16-bit Microcontroller datasheet.

Table 18. Revision History (Sheet 1 of 2)

Revision	ltem	Change
002	All	Data sheet moved from Product Preview to Advance Information status.
002	Cover	List of features changed to reflect 24 Kbytes of OTPROM and 768 bytes of register RAM.
002	Figure 3	Modified to include PLLEN designation on pin 6.
002	Table 4	Signal descriptions modified for the PLLEN pin, to reflect the method for bypassing the on-chip PLL.
002	Section 6.0	Changed "PLL in 1x mode" to "PLL bypassed".

Revision	ltem	Change	
002	Section 6.1	Changes to DC Characteristics as follows: I _{CC} Max from TBD to 95 mA I _{REF} Max from TBD to 5 mA I _{IDLE} Max from TBD to 42 mA PDDeleted IHDeleted IHDeleted IGL2 (All pins except P2.6) Min, Max, @ V _{OL2} from TBD to: Min = 15 mAMax = 110 µA@ V _{OL2} = 1.0 V Min = 30 mAMax = 185 µA@ V _{OL2} = 2.5 V Min = 35 mAMax = 215 µA@ V _{OL2} = 4.0 V R _{WPU} replaced with R _{WPD2} to accurately reflect the weak pulldown device. Typical set to 100 KΩ for all pins except P2.6. I _{OL2} (Added for P2.6 only) Min = 0.4 mAMax = 2.0 µA@ V _{OL4} = 1.0 V Min = 1.2 mAMax = 4.0 µA@ V _{OL4} = 4.0 V R _{WPD4} (Added for P2.6 only) To accurately reflect the weak pulldown device for P2.6. Typical set to 3 KΩ.	
002	Table 9	$ \begin{array}{l} \mbox{Changes to AC Characteristics as follows:} \\ \mbox{${\rm T}_{\rm CHCL}$Max from T+15 to T+20 ns$} \\ \mbox{${\rm T}_{\rm CLLH}$Max from 15 to 30 ns$} \\ \mbox{${\rm T}_{\rm LLCH}$Min from -20 to -35 ns$} \\ \mbox{${\rm T}_{\rm RLCL}$Min from 4 to 0$} \\ \mbox{${\rm T}_{\rm RLAZ}$Max from 5 to 10 ns$} \\ \mbox{${\rm T}_{\rm CHWH}$Min from -10 to -5 ns$} \\ \mbox{${\rm Max from 15 to 30 ns$}$} \end{array} $	
002	Table 11 and Figure 5	Added External clock drive specifications and waveform.	
002	Figure 6	Added AC testing input/output waveform.	
002	Figure 7	Added Float Waveform.	
002	Section 7.2	Added EPROM specifications for programming characteristics.	
002	Section 8.0	Added A/D converter specifications.	
002	Section 9.0	Added AC characteristics for the serial port.	
003	All	Changed V_{CC} and V_{REF} operating spec conditions.	

Table 18. Revision History (Sheet 2 of 2)